2SA1762

Silicon PNP epitaxial planar type

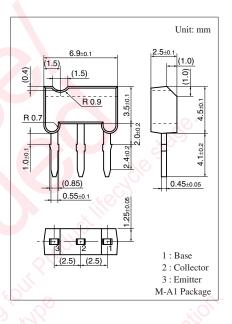
For low-frequency driver amplification Complementary to 2SC4606

Features

- High collector-emitter voltage (Base open) V_{CEO}
- Optimum for the driver stage of a low-frequency and 25 W to 30 W output amplifier

Absolute Maximum matings $T_a = 25 \text{ C}$					
Parameter	Symbol	Rating	Unit		
Collector-base voltage (Emitter open)	V _{CBO}	-80	V		
Collector-emitter voltage (Base open)	V _{CEO}	-80	V		
Emitter-base voltage (Collector open)	V _{EBO}	-5	V		
Collector current	I _C	- 0.5	А		
Peak collector current	I _{CP}	-1	Α		
Collector power dissipation *	P _C	1	W		
Junction temperature	Tj	150	°C		
Storage temperature	T _{stg}	-55 to +150	°C		





Note) *: Printed circuit board: Copper foil area of 1 cm² or more, and the board thickness of 1.7 mm for the collector portion

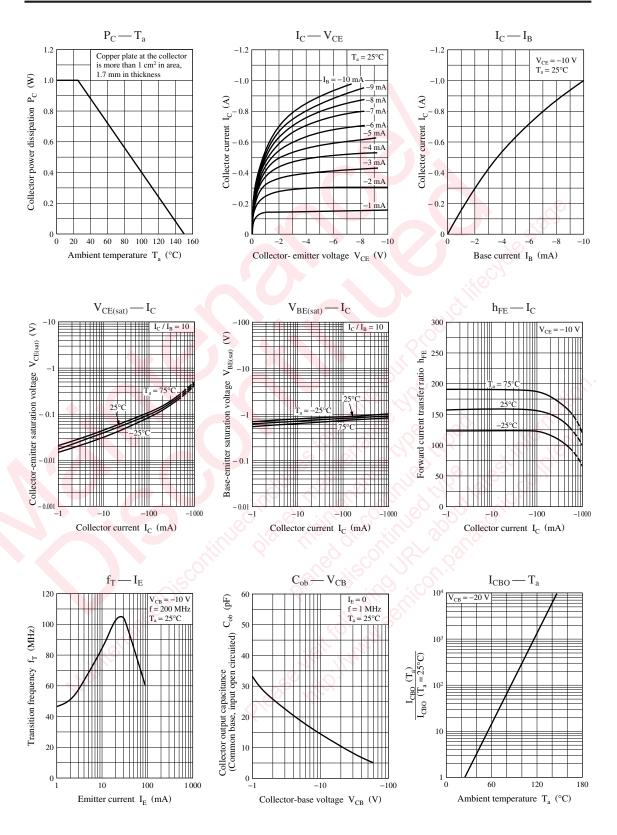
Electrical Characteristics $T_a = 25^{\circ}C \pm 3^{\circ}C$

Parameter	Symbol	Conditions	Min	Тур	Max	Unit
Collector-base voltage (Emitter open)	V _{CBO}	$I_{\rm C} = -10 \ \mu A, I_{\rm E} = 0$	-80	8		V
Collector-emitter voltage (Base open)	V _{CEO}	$I_{\rm C} = -100 \ \mu A, I_{\rm B} = 0$	-80			V
Emitter-base voltage (Collector open)	V _{EBO}	$I_{\rm E} = -10 \ \mu A, I_{\rm C} = 0$	-5			V
Collector-base cutoff current (Emitter open)	I _{CBO}	$V_{CB} = -20 \text{ V}, I_E = 0$			- 0.1	μΑ
Forward current transfer ratio *1	h _{FE1} *2	$V_{CE} = -10 \text{ V}, I_C = -150 \text{ mA}$	130		330	_
	h _{FE2}	$V_{CE} = -5 \text{ V}, \text{ I}_{C} = -500 \text{ mA}$	50	100		
Collector-emitter saturation voltage	V _{CE(sat)}	$I_{\rm C} = -300 \text{ mA}, I_{\rm B} = -30 \text{ mA}$			- 0.4	V
Base-emitter saturation voltage	V _{BE(sat)}	$I_{\rm C} = -300 \text{ mA}, I_{\rm B} = -30 \text{ mA}$			-1.2	V
Transition frequency	f _T	$V_{CB} = -10 \text{ V}, I_E = 50 \text{ mA}, f = 200 \text{ MHz}$		120		MHz
Collector output capacitance	C _{ob}	$V_{CB} = -10 \text{ V}, I_E = 0, f = 1 \text{ MHz}$		11	20	pF
(Common base, input open circuited)						

Note) 1. Measuring methods are based on JAPANESE INDUSTRIAL STANDARD JIS C 7030 measuring methods for transistors.

2. *1: Pulse measurement

*2: Rank classification						
Rank	R	S				
h _{FE1}	130 to 220	185 to 330				





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